JULY RECOPCITY I SERVE LIGHTED 2001 ATTY DOCKET NO. U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE Form PTO 1449 (Modified) New US PCT application 09/426 81 217206US3PCT based on PC 1/JP01/02420 APPLICANT LIST OF REFERENCES CITED BY APPLICANT Yoshihiko FUNAKOSHI, et al. FILING DATE 6/1/02 Herewith 2 881 U.S. PATENT DOCUMENTS DOCUMENT FILING DATE **EXAMINER** SUB DATE CLASS NAME NUMBER INITIAL CLASS IF APPROPRIATE ÆΑ AB AC AD ΑĘ ΑF AG ΑН ΙA pesi Available Copy AJ ΑK AL AM AN FOREIGN PATENT DOCUMENTS DOCUMENT TRANSLATION DATE COUNTRY NUMBER YES NO JAPAN 2000-009897 01/14/00 AO AP **GERMANY** 19882537 05/18/00 JAPAN 2001-0832810 03/30/01 AQ 51-046670 04/21/76 JAPAN AR AS 03-106532 05/07/91 **JAPAN** ΑT 006135/1990 01/16/90 JAPAN JAPAN AU 54-127859 10/04/79 OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.) AW AY AZ. Additional References sheet(s) attached Examiner **Date Considered** *Examiner: Initial If reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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